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LM UNIT ROOT TEST WITH PANEL DATA; A TEST ROBUST TO STRUCTURAL CHANGES*

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Abstract

This paper proposes an LM test for the unit root hypothesis using panel data. The LM statistic based on the pooled likelihood function is obtained by standardizing the average of the LM statistic for individual time series. Under the null hypothesis, the statistic follows the standard normal distribution in the limit as N; T! 1 as long as N=T approaches any ...nite number, regardless of whether structural breaks are present. According to the Monte Carlo simulation results, the LM test is robust to the presence of structural breaks, and is more powerful than the popular test proposed by Im, Pesaran and Shin (1997) in the benchmark case where no structural breaks are involved.

JEL Classi...cation: C12, C15, C22, C23

Key Words: Heterogeneous Dynamic Panels, Unit Root, LM Test,

Structural Change.

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1. Introduction

Recent development of panel data-based unit root tests has attracted much attention in applied work. In particular, the tests proposed by Levin and Lin (1993) and Im, Pesaran and Shin (1997, IPS hereafter) have been widely applied. The statistics of both tests follow the standard normal distribution under the null hypothesis that all time series contain a unit root. However, the IPS test, which is obtained by standardizing the average of the augmented Dickey-Fuller (ADF) t-statistics, appears more promising. It requires a weaker condition that N=T approaches any ...nite number as N and T ! 1; while the Levin and Lin test requires a stronger restriction that N=T goes to zero. IPS provide simulation evidence that their test performs better as compared to the Levin and Lin test.

In this paper we develop a new panel unit root test based on the Lagrangian multiplier (LM) principle. The panel LM test based on the pooled likelihood function is given as the sum of the N individual LM statistics for each time series. Since the sum of individual statistics approaches a normal random variable as N increases, we can construct a convenient standard normal test through appropriate standardization. In the basic case where the errors in individual time series are serially uncorrelated, the panel LM statistic follows a standard normal distribution under the null hypothesis as N ! 1 (for ...xed T), as long as the second moment of the individual LM statistic exists. When the errors are serially correlated, we conjecture, based on the results in IPS and our simulation results, that the limiting distribution of the panel LM statistic is also standard normal unless N=T diverges as N; T ! 1.

Although the procedure of the panel LM test resembles that of IPS, it has an important advantage in dealing with structural breaks. Perron (1989) showed that the augmented Dickey-Fuller (ADF) unit root tests suxer from loss of power when the existing structural break is ignored. Because the IPS statistic is obtained as a linear combination of the ADF statistics of the individual time series, we would expect a similar pattern of power loss in the IPS test when the existing break in each time series is ignored. Naturally, one may suggest to modify the IPS test by including a dummy variable in each ADF regression to control for the exect of the structural break. This approach, however, relays to another dif...cult problem. As is well known, the limiting distribution of the ADF t-statistic depends on the location of the break when it allows for a structural break. Thus, the IPS procedure of standardizing the average of the ADF statistics requires the expected values and variances of the ADF t-statistics for all dixerent locations of the break points in the sample.

The situation is very dixerent when it comes to the LM approach. Schmidt and Phillips (1992) derived the LM test for the unit root hypothesis in a single time series. In a sequel, Amsler and Lee (1995) showed that the dependence of the LM statistic on the nuisance parameter indicating the position of the break disappears as T ! 1. This asymptotic invariance property of the LM

test for single time series turns out to carry over to the panel unit root test. When structural breaks are present, we suggest to follow the same standardization procedure using the same expected values and variances used in the basic case where no structural breaks are involved. Then there arises a subtle problem. The invariance of the individual LM statistic to the location of the break point is an asymptotic result. The dependence of the test statistic on the break point vanishes only at the order of T^{i} and this discrepancy of order T^{i} for each time series accumulates as N increases at the rate of N: Yet, we show that the dependence of the expected values of the individual LM statistic on the location of the break point vanishes at the rate of T^{i} . This result permits us to claim that the panel LM test remains valid as long as N=T does not diverge as N; T! 1 and the second moment of the individual LM statistic exists for all T $_{\circ}$ T_{0} ; for some ...nite T_{0} .

The LM test is ‡exible. It can be applied when a structural break occurs at di¤erent time period in each time series as well as when the structural break occurs in only some of the time series.

The ...nite sample performance of the LM test is examined via Monte Carlo simulation. The N=T asymptotic result is generally supported in our simulation. All empirical sizes of the LM tests that properly control for the structural breaks are reasonably close to the nominal size in all N; T cases we examined. In addition, the LM test is more powerful than the IPS test in the basic case when no structural breaks occur.

The paper is organized as follows. In the next section we present the model and derive the panel LM statistic when the time series contain no structural breaks. In Section 3 we extend the test to the case when a structural break is present in each time series. In Section 4 we report simulation results. Section 5 concludes.

2. LM Test with No Structural Break

Suppose we have data y_{it} ; t = 1; 2; ...; T; i = 1; 2; ...; N; generated as:

$$y_{it} = x_{it} + z_{it}; \quad x_{it} = A_i x_{i;t_i 1} + "_{it}; \quad z_{it} = {}^{\circ}_{1i} + {}^{\circ}_{2i}t:$$
 (2.1)

We are interested in testing the null hypothesis of unit roots $A_i = 1$ for all i. To do so, we express y_{it} as:

where $\bar{a}_i = \bar{a}_i$ (1 \bar{a}_i): We then have the null hypothesis:

$$H_0: \bar{i} = 0 \text{ for all } i;$$
 (2.3)

against the alternatives:

$$H_1: \bar{i} < 0; i = 1; 2; \dots; N_1, \bar{i} = 0; i = N_1 + 1; N_1 + 2; \dots; N:$$
 (2.4)

Therefore, all or some of the time series are stationary under the alternative hypothesis.

This section is divided into two subsections. First, we study the simple case when the errors, $"_{it}$; are uncorrelated. In the second subsection we deal with the serially correlated errors.

2.1. Serially Uncorrelated Errors

First we derive the LM statistic in the basic case when the errors, "it; in (2.2) are serially uncorrelated. We assume:

Assumption 2.1. " $_{it}$; i=1; ...; N; t=1; ...; T, are independent normal variables with mean zero and variance $\frac{3}{4}$.

We then have the following pooled log-likelihood function:

$$\ln L = \frac{\cancel{N}}{i} \frac{\mu}{2} \ln 2 \frac{1}{2 \frac{3}{4} i} \operatorname{SSE}_{i};$$
(2.5)

where

$$SSE_{i} = \sum_{t=1}^{X} f \Phi y_{it | i} - y_{i;t_{i} | 1} + - \alpha_{i} \alpha_{1i | i} [1_{i} - \alpha_{i} (t_{i} | 1)] \alpha_{2i} g^{2} : \qquad (2.6)$$

If we let LM_{iT} be the LM statistic for the i-th time series, then it is straightforward to see that the LM statistic based on the pooled likelihood function (2.5) becomes

$$LM_{NT} = \underset{i=1}{\overset{\mathbf{X}}{\times}} LM_{iT}: \qquad (2.7)$$

Let

$$\hat{S}_{i;t_{i}} = y_{i;t_{i}} \cdot i \cdot \hat{S}_{2i}(t_{i} \cdot 1); \tag{2.8}$$

where $\mathring{\gamma}_{2i} = \frac{1}{T} \mathsf{P}_{t=1}^T \mathsf{C} \mathsf{y}_{it} = (\mathsf{y}_{iT} \; \mathsf{j} \; \mathsf{y}_{i0}) = \mathsf{T}$ is the restricted maximum likelihood estimator of $\mathring{\gamma}_{2i}$ obtained from the restricted regression:

Schmidt and Phillips (1992) proposed an LM statistic obtained as the t-statistic testing $_{i}^{-}$ = 0 in the regression

$$\Phi_{it} = intercept + \bar{S}_{i;t_{i-1}} + error; \qquad (2.10)$$

which could be expressed as

$$LM_{iT} = \frac{p_{\overline{1}}^{3} \hat{S}_{i;_{i}}^{0} M_{(i_{T})} \hat{C}Y_{i}}{\hat{S}_{i}^{0} M_{(i_{T})} \hat{S}_{i}^{1} \hat{C}Y_{i}^{0} M_{(i_{T}; \hat{S}_{i-1})} \hat{C}Y_{i}}; \qquad (2.11)$$

where $\Phi Y_i = (\Phi y_{i1}; \Phi y_{i2}; ...; \Phi y_{iT})^0$; $\hat{S}_{i;i} = \hat{S}_{i0}; \hat{S}_{i1}; \hat{S}_{i2}; ...; \hat{S}_{i;T_i} = \hat{S}_{i0}; \hat{S}_{i1}; \hat{S}_{i2}; ...; \hat{S}_{i;T_i} = \hat{S}_{i0}; \hat{S}_{i1}; \hat{S}_{i2}; ...; \hat{S}_{i|T_i} = \hat{S}_{i1}; \hat{S}_{i1}; \hat{S}_{i2}; ...; \hat{S}_{i|T_i} = \hat{S}_{i1}; \hat{S}_{i1}; \hat{S}_{i2}; ...; \hat{$

The distribution of LM_{NT} in (2.7) depends on N and T; but not on any other nuisance parameters under the null hypothesis. Therefore, LM_{NT} itself may be used in practice as a test statistic. However, as N increases, as long as the second moment of LM_{iT} exists, the distribution of LM_{NT} will approach a normal distribution. We denote the average of the individual LM statistic LM_{iT} in (2.11) as

$$\overline{LM}_{NT} = \frac{1}{N} \sum_{i=1}^{N} LM_{iT}; \qquad (2.12)$$

and the expected value and variance of LM_{iT} de...ned in (2.11) under the null hypothesis as $E(L_T)$ and $V(L_T)$: More formally,

De...nition 1. E (L_T) and V (L_T) are the mean and variance of the LM statistic obtained as the t-statistic for testing $\bar{}$ = 0 in the regression (2.10), where y_t follows a simple random walk:

$$\Phi y_t = "_t$$
; with "_t » iidN ⁱ0; $\frac{1}{4}$ for $t = 1; 2; ...; T$; and $y_0 = 0$: (2.13)

Then, under Assumption 2.1, and under the null hypothesis,

$$_{i LM} = \frac{P \overline{N} \frac{\mathbf{f}}{LM}_{NT \ i} E (L_{T})^{\mathbf{g}}}{P \overline{V (L_{T})}}) N(0;1)$$
 (2.14)

as N grows (for ...nite T), as long as E (L_T) and V (L_T) exist.

Remark 1. We could not prove the existence of $E(L_T)$ and $V(L_T)$ for some ...nite T, and the statement (2.14) remains to be a conjecture. A similar di¢-culty was addressed in IPS. This technical di¢-culty disappears if we stick to the

LM principle. Schmidt and Phillips (1992) suggested to estimate $\frac{3}{i}^2$ based on the unrestricted SSE_i in (2.6). However, following the LM principle, we may estimate $\frac{3}{i}^2$ based on the restricted SSE_i or from the restricted regression (2.9), namely: $\frac{3}{i}^2 = T_i \frac{1}{3} \int_{t=1}^{T} (\Phi y_{it} i)^2 \frac{1}{2} \frac{1}{3} \int_{t=1}^{T} (\Phi y_{it} i)^2 \frac{1}{3$

Remark 2. As was noted in Schmidt and Phillips (1992), the statistic LM_{iT} is invariant numerically to the values of $^{\circ}_{1i}$ and $^{\circ}_{2i}$ under the null hypothesis. Therefore we do not lose generality by setting $^{\circ}_{1i} = ^{\circ}_{2i} = 0$ in the data generation process of (2.13).

2.2. Serially Correlated Errors

In this subsection, we assume that the errors, "it; in (2.2) follow an autoregressive process.¹

Assumption 2.2. " $_{it} = P_{\substack{p_i\\j=1}} \aleph_{ij}$ " $_{it_i \ j} + e_{it}$; i=1; ...; N; t=1; ...; T; where e_{it} are independent normal variables with mean zero and variance \aleph_i^2 , and all the roots of \aleph_i (z) = 1 $_i$ $_{j=1}^{p_i} \aleph_{ij} z^j$ lie outside the unit circle.

We follow Ahn (1993) and Amsler and Lee (1995) who suggested an ADF type correction for serially correlated errors in (2.2). The LM statistic for the i-th time series is obtained as a t-statistic for $\bar{}_{i} = 0$ in the augmented regression:

where p_i denotes the order of augmentation for the i-th times series, and $\hat{S}_{i;t_i \ 1}$ is de…ned in (2.8).² See Remark 3 below for more details of the construction of

¹We do not pursue the asymptotics of the LM test when the errors are serially correlated in this paper. IPS presented the asymptotic result that the IPS test is valid in the presence of AR(p) errors as long as N=T converges to any ...nite number as N;T! 1: We conjecture that the LM test would be valid under the same conditions for AR(p) errors. As we discuss in Section 4, no asymptotic result for panel unit root tests is available when the errors follow moving average processes.

²Amsler and Lee (1995) suggested to augment $\Leftrightarrow \hat{S}_{i;t_i j}$ rather than $\Leftrightarrow y_{i;t_i j}$. But, in the case where no structural breaks are involved, they produce numerically identical statistics.

 $\hat{S}_{i;t_i,1}$ in practice. Let the resulting t-statistic be LM_{iT} (p_i) and the average

$$\overline{LM}_{NT}(p) = \frac{1}{N} \sum_{i=1}^{N} LM_{iT}(p_i): \qquad (2.16)$$

We follow the standardization procedure proposed by IPS. To do so, we de…ne the expected value and variance of $LM_{iT}(p_i)$; when $\bar{p}_i = 0$ and $\bar{p}_{ij} = 0$; for j = 1; ...; p_i :

De...nition 2. E [L_T (p_i)] and V [L_T (p_i)] are the mean and variance of the LM statistic obtained as the t-statistic for testing $\bar{q}_i = 0$ in the regression (2.15), where y_{it} follows a simple random walk process:

$$\Phi_{it} = i_{it}$$
; with $i_{it} \gg i i dN i_{0}$; $\psi_{it}^2 = i_{it}$; for $t = 1; 2; ...; T$; and $\psi_{i0} = 0$: (2.17)

Then, the standardization of \overline{LM}_{NT} (p) using E [L_T (p_i)] and V [L_T (p_i)] yields:

$$_{i LM}(p) = \frac{P_{\overline{N}}^{n} \frac{n}{LM_{NT}(p)_{i} \frac{1}{N} P_{i=1}^{N} E[L_{T}(p_{i})]}}{\frac{1}{N} P_{i=1}^{N} V[L_{T}(p_{i})]} :$$
(2.18)

The statistic LM_{iT} (p_i) is invariant numerically to the values of °_{1i} and °_{2i} under the null hypothesis, so that we do not lose generality by setting °_{1i} = °_{2i} = 0 in the data generation process in (2.17). (See Remark 2.) However, LM_{iT} (p_i) does depend on the values of ½_{ij} for ...nite T; even though this dependence disappears as T grows. Therefore, $E[L_T(p_i)]$ and $V[L_T(p_i)]$ are not the exact expected value and variance of $LM_{iT}(p_i)$. This prompts a complicated issue that under which condition the test based on $_{iLM}$ (p) is valid. We avoid this issue in this paper. But, in light of the simulation results reported in Section 4 and the results in IPS, it seems to follow that

$$_{i LM}(p)) N(0;1);$$
 (2.19)

unless N=T diverges as both N and T! 1:

The expected values and variances, E [L_T (p)] and V [L_T (p)]; for various cases of T and p are computed via stochastic simulation based on 500,000 replications, and are provided in Table 1. (See Remark 3 for more details.) Note that i_{LM} in (2.14) is a special case of i_{LM} (p) when $p_i = 0$; for all i:

Remark 3. Notes on the use of Table 1:

(1) The value of T in Table 1 denotes the regression dimension. For example, suppose that someone has 25 observations for the i-th time series and wants to allow $p_i = 2$: Then, the regression dimension is 22 so that the appropriate expected value and variance corresponding to T = 22 and p = 2 are j = 1.880 and

0:413; respectively.

- (2) In computation of E [L_T (p)] and V [L_T (p)] (with T+p+1 data points available), we constructed the series $\hat{S}_{t_i \ 1}$ as $\hat{S}_{t_i \ 1} = y_{t_i \ 1 \ i}$ ($y_{T+p+1 \ i} \ y_1$) =(T + p): We recommend to construct the series $\hat{S}_{i:t_i \ 1}$ in the same way.

3. Panel LM Test with Break

In this section we derive an LM test for unit root hypothesis in panel data where a structural break is present in each individual time series. We have two subsections. The errors are serially uncorrelated in the ...rst subsection. Serially correlated errors are introduced in the second subsection.

3.1. Serially Uncorrelated Errors

Suppose structural shift occurs at time period $T_{B;i}$ in i-th time series. Therefore, the data are generated as:

$$y_{it} = x_{it} + z_{it}; \quad x_{it} = A_i x_{i;t_i 1} + i_{it}; \quad z_{it} = i_{1i} + i_{2i} t + i_{1i} D_{it};$$
 (3.1)

for t = 0; 1; 2; ...; T; i = 1; 2; ...; N; where

$$D_{it} = \begin{cases} \frac{1}{2} & 0 & t < T_{B;i} \\ 1 & t \leq T_{B;i} + 1; \end{cases}$$
 (3.2)

which has an alternative representation:

for t = 1; 2; ...; T; i = 1; 2; ...; N; where $\Phi D_{it} = D_{it \ i} \ D_{i;t_{i} \ 1};$ i.e.,

$$\Phi D_{it} = \begin{pmatrix} \frac{1}{2} & 1 & t = T_{B;i} + 1 \\ 0 & otherwise. \end{pmatrix}$$
 (3.4)

From (3.3), under Assumption 2.1, we obtain the pooled likelihood function (2.5) with

$$SSE_{i} = \frac{X}{t=1} f \oplus y_{it \ i} \ _{i}^{-} y_{i;t_{i} \ 1} + _{i}^{-} \circ_{1i \ i} \ [1_{i} \ _{i}^{-} (t_{i} \ 1)] \circ_{2i \ i} \ (\oplus D_{it \ i} \ _{i}^{-} D_{it}) \pm_{i} g^{2} :$$

$$(3.5)$$

As Amsler and Lee (1995) suggested, the LM statistic for the i-th time series can be obtained as a t-statistic for testing $\bar{a} = 0$ in the regression:

$$\Phi_{it} = {}^{\circ}_{2i} + \pm_{i} \Phi_{it} + {}^{-} \Re_{i;t_{i}} + \text{error};$$
 (3.6)

where

$$S_{i;t_{i},1} = y_{i;t_{i},1} \sum_{j=1}^{n} (t_{j},1) \sum_{i} \Xi_{i} D_{i;t_{i},1};$$
 (3.7)

and $\hat{\gamma}_{2i}$ and $\hat{\tau}_{i}$ are the OLS estimators of $\hat{\gamma}_{2i}$ and $\hat{\tau}_{i}$ in the restricted regression:

we have the LM statistic for the i-th time series:

$$LM_{iT}^{B} = \frac{P_{3}^{3}}{S_{i;i}^{0}M_{(i_{T};\Phi D_{i})}\Phi Y_{i}} : (3.9)$$

$$S_{i;i}^{0}M_{(i_{T};\Phi D_{i})}S_{i;i}^{0} \Phi Y_{i}^{0}M_{(i_{T};\Phi D_{i};S_{i;i},1)}\Phi Y_{i}$$

The panel LM statistic based on the pooled likelihood function is given by the sum of LM_{iT}^B so that $LM_{NT}^B = \prod_{i=1}^N LM_{iT}^B$: Let

$$\overline{LM}_{NT}^{B} = \frac{1}{N} \sum_{i=1}^{M} LM_{iT}^{B}$$
: (3.10)

As Amsler and Lee (1995) showed, the distribution of LM_{iT} does not depend on the location of the break point

$$_{si} = \frac{T_{B;i}}{T} \tag{3.11}$$

in the limit, i.e., $LM_{iT}^{B}iLM_{iT} = o_{p}(1)$: In ...nite sample, however, the distribution of LM_{iT}^{B} does depend on $_{i}$. If we have the exact expected value and the exact variance of LM_{iT}^B under the null hypothesis, which we denote as $E^-L_T^B$ ($_i$) and $V^{L_T^B}(s_i)$; then it follows that

$$i_{LM}^{B^{\pi}} = \frac{P_{N}^{n} \frac{1}{LM_{b} i_{j}} \frac{1}{N} P_{i=1}^{N} E^{f} L_{T}^{B} (_{s}i)^{\pi}}{P_{i=1}^{N} V [L_{T}^{B} (_{s}i)]}) N (0;1);$$
(3.12)

under the null hypothesis, as N ! 1; as long as V $L_T^B(\underline{\ }_i)$ exists for all i. However, the statistic $\underline{\ }_{LM\pi}^{B\pi}$ as it stands, is not very practical since it requires $E L_T^B(\underline{\ }_i)$ and V $L_T^B(\underline{\ }_i)$ for all $\underline{\ }_i$ in the sample.

Since LM_{iT}^{B} i $LM_{iT} = o_{p}$ (1); we consider a practical statistic using $E(L_{T})$ and $V(L_T)$ de...ned in De...nition 1 in place of $E^{T}L_T^{B}(x_i)$ and $V^{T}L_T^{B}(x_i)$ in (3.12) to have

$$i_{LM}^{B} = \frac{P_{\overline{N}}^{h} \frac{h}{LM_{NT}^{B}} i_{LT}^{B} E_{LT}^{i}}{P_{\overline{V}(L_{T})}} :$$
(3.13)

The issue now is under which condition we have

$$_{i LM}^{B}$$
) N (0; 1): (3.14)

The result in (3.14) holds if

$$i_{LM}^{B} i_{LM}^{i} = 0_{p} (1) :$$
 (3.15)

We focus on the condition that guarantees (3.15). In doing so, we assume:

Assumption 3.1. The variance of L_T de...ned in De...nition 1 and the variance of L_T^B (3) used in (3.12), for all values of 3; are ...nite for all T 3 T₀ for some ...nite T_0 . (See Remark 4 below.)

Note that

$$i \stackrel{B}{LM} i \stackrel{B}{i} \stackrel{B}{LM} = \frac{P_{\overline{N}} \stackrel{h}{LM}_{NT} \stackrel{B}{i} \stackrel{E}{E} (L_{T})}{P_{\overline{V}} (L_{\overline{T}})} i \stackrel{P}{\overline{N}} \stackrel{n}{LM}_{NT} \stackrel{h}{i} \stackrel{P}{\overline{N}} \stackrel{E}{L}_{i=1}^{B} \stackrel{E}{E} \stackrel{L_{\overline{B}}}{L_{T}^{B}} (\underline{I}_{i})^{B} (\underline{I}_{i})^{B}$$

It is shown in Appendix that

$$L_{T}^{B}(_{s})_{i} L_{T} = O_{p}^{i} T_{i}^{1=2}$$
; for all $_{s}$: (3.17)

 $L_{T}^{B}\left(\begin{subarray}{c} \begin{subarray}{c} \begin{subarr$ view that the ...rst term of the last equation of (3.16) is o_p (1). Now we need to ...nd

$$E^{\mathbf{f}}_{L_{T}^{B}(s)_{i}} L_{T}^{\mathbf{g}} = O^{\mathbf{i}}_{T_{i}} T_{s}^{\mathbf{f}}^{\mathbf{f}}; \text{ for all } s$$
 (3.18)

Therefore, $N^{i} \stackrel{1=2}{\overset{\overset{1=2}{\overset{1=2}{\overset{1=2}{\overset{1=2}{\overset{1=2}{\overset{1=2}{\overset{1=2}{\overset{1=2}{\overset{1=2}{\overset{$ o_p (1) unless N=T diverges at the rate of $\stackrel{p}{T}$ or faster as N; T ! 1.

Remark 4. The uniform integrability of L_T and L_T^B ($_{\tt s}$) is something to be veri...ed rather than assumed. The di¢culty disappears if $\frac{1}{4}$ is estimated based on the restricted MLE. Then the uniform integrability condition is obviously met since both L_T and L_T^B ($_{\tt s}$) are bounded by \overline{T} : (See Remark 1.) Following our simulation results, the second moment of L_T^B ($_{\tt s}$) exists for T as small as 7.

Remark 5. Because the claim in (3.18) is at the center of the proof, we conduct a simulation to see how TE $L_T^B(\]_i$ L_T changes as T_f grows. In the following Table the expected value and standard deviation of T $L_T^B(\]_i$ L_T are computed based on 50,000 replications with $\]_i = 0.5$:

f T ¤	100	1,000	10,000	100,000
$T_{\mathbf{r}}^{\mathbf{F}} L_{T}^{B}(\mathbf{s})_{i} L_{T}$	-0.012	0.287	-0.254	-0.331
$T^{V}[L_{T}^{B}(], L_{T}]$	10.118	30.910	97.795	307.480

As is seen, $T \in L_T^B(\)_{i \in L_T}^B$ ‡uctuates within a very narrow interval, while the standard deviation of $T \in L_T^B(\)_{i \in L_T}^B$ shows an apparent tendency of creeping up at the rate of T; which supports the claims in (3.17) and (3.18).

3.2. Serially Correlated Errors

When the errors " $_{it}$ in (3.3) are serially correlated, their exect can be corrected by augmenting $\mathfrak{S}_{i;t_i\,j}$; as suggested in Amsler and Lee (1995). Therefore, the LM statistic for the i-th time series is obtained as a t-statistic for $\bar{}_i = 0$ in the augmented regression:

where $S_{i;t_i 1}$ is de...ned in (3.7). We de...ne LM_{iT}^B (p_i) as the t-statistic for $\bar{p}_i = 0$ in regression (3.19), and its average

$$\overline{LM}_{NT}^{B}(p) = \frac{1}{N} \sum_{i=1}^{M} LM_{iT}^{B}(p_i):$$
 (3.20)

We then follow the standardization procedure described in Section 2.2 to derive

$$i_{LM}^{B}(p) = \frac{p_{\overline{N}} \frac{n_{LM}^{B}(p)}{LM_{NT}^{B}(p)} \frac{1}{n_{i=1}^{N}} \frac{p_{N}^{D}(p_{i})}{p_{i=1}^{N}} E[L_{T}(p_{i})]}{\frac{1}{n_{i=1}^{N}} V[L_{T}(p_{i})]}; \quad (3.21)$$

where $E[L_T(p_i)]$ and $V[L_T(p_i)]$ are de...ned in De...nition 2 of Section 2.2.

In view of the simulation results reported in Section 4 and the results in IPS, we conjecture that

$$_{i LM}(p)) N(0;1);$$
 (3.22)

unless N=T diverges as N; T! 1:

4. Simulation Results

In this section we investigate the small sample properties of the LM test for unit root using panel data. We also compare the performance of the LM test with the IPS test when no structural breaks are present.

Three experiments are conducted. In the ...rst experiment, we simulate the basic case where the data contain no structural breaks and the errors are serially independent. The ...rst experiment is designed to compare the generic power of LM vis-a-vis IPS. In the second experiment we include structural breaks in the data generation process while the errors are serially independent. We investigate the consequence of ignoring existing breaks as well as the performance of the LM test that controls for structural breaks. Special attention is paid to how the asymptotic result of N=T derived in Section 3.1 works in ...nite samples. The third experiment investigates the case where the errors are serially correlated and a structural break is present in each time series. We consider only the LM test that controls for structural breaks.

In the ...rst two experiments where no serial correlations are involved, we report the results for 16 combinations of N; T = 10; 25; 50; 100: But, in the third experiment, where the data contain structural breaks and the errors are serially correlated, we drop T = 10 because the degrees of freedom problem becomes serious. Therefore, we are left with only 12 combinations of N = 10; 25; 50; 100 and T = 25; 50; 100: In each case the results are based on 2,000 replications. In each replication we generate N independent time series of T + 1 data points using pseudo-iid N (0,1) random numbers from the Gauss RNDNS procedure. Therefore, the regression dimension is T $_{\rm i}$ p. The ...rst 50 observations are discarded to avoid a possible initial value exect. All tests are conducted using the 5% nominal size.

4.1. Experiment 1: No Breaks, No Serial Correlations

In the ...rst experiment, each time series contains no structural break, and the errors are serially uncorrelated. N independent time series are generated as:

$$y_{it} = A_i y_{i;t_{i-1}} + "_{it}; t = 0; 1; ...:T; i = 1; 2; ...; N;$$
 (4.1)

with " $_{it}$ » iid N (0; 1): We set $A_i = 1$ for the examination of the empirical size and $A_i = 0.9$ for the power computation for all i. We compare the performance of the LM test based on the statistic $_{i \text{ LM}}$ given in (2.14) and the IPS test obtained by standardizing the average of the t-statistics from the DF regressions that include an intercept and linear trend (see IPS, 1997, equations 2.2 and 4.2). The results are reported in Table 2.

Since both the LM and IPS statistics follow the standard normal distribution as N increases (with ...xed T) under the null hypothesis, we expect the empirical size reasonably close to the 5% nominal size in both tests for relatively large N.

As expected, all reported sizes are reasonably close to 5%, even for the case with N = 10.

Comparing the power of the tests, the LM test turns out more powerful than the IPS test. For example, when $N=100;\,T=25;\,$ the power of LM is 0:518; while the power of IPS is 0:415: The corresponding sizes are 0.060 and 0.063. When $N=25;\,T=50;\,$ the power of LM is 0:802 and the power of IPS is 0:622, while the corresponding sizes are 0:058 and 0:059; respectively.

It is observed that the power increases more rapidly with T than with N for both tests. A similar pattern was reported by IPS in their paper. For instance, when T=10 the power is close to the size even with N=100 in both tests.

4.2. Experiment 2: Structural Breaks, No Serial Correlations

In the second experiment we investigate the exect of structural breaks. A structural break occurs at $T_{B;i}$ for the i-th time series with the magnitude of shift \pm_i . The data generation process follows:

$$y_{it} = x_{it} + z_{it}; \quad x_{it} = \hat{A}_i x_{i;t_i 1} + "_{it}; \quad z_{it} = \pm_i D_{it};$$
 (4.2)

We consider two cases. In the ...rst case, all the structural breaks occur at the middle of the series so that $_{\downarrow i} = T_{B_i} = T = 0.5$ for all i: The structural breaks occur earlier in the second case at $_{\downarrow i} = 0.3$ for all i. $D_{it} = 0$ for $t < \frac{T}{2}$ and 1 otherwise for the ...rst case, and $D_{it} = 0$ for $t < \frac{T}{3}$ and 1 otherwise for the second case. In both cases, $\frac{3}{4}_i = 1$ and $\frac{1}{2}_i = \frac{1}{4}_i = 5$ for all i:

We experiment with three tests: the LM test based on the statistic $_{i LM}$ de...ned in (2.14); the IPS test based on the statistic described in the previous subsection; and the LM test based on the statistic $_{i LM}^{B}$ de...ned in (3.13), which we will refer to respectively as LM_N, IPS_N and LM_B to signify that LM_N and IPS_N ignore the existing breaks, but LM_B controls for the breaks. The results are reported in Table 3.

An obvious pattern from Table 3 is that the situation is worse in panel, and gets worse as N increases. For example, in the ...rst panel ($_{\circ} = 0.5$); when T = 25 and N = 10, 25, 50, 100; the respective empirical sizes of IPS_N are 0:017; 0:016, 0:007; 0:005, and the corresponding ...gures of LM_N are 0:025, 0:022, 0:009, 0:004: Although the empirical sizes get closer to the nominal size as T increases, a similar pattern of size distortion is observed even with T = 100: The sizes of IPS_N and LM_N are even worse in the second panel ($_{\circ} = 0.3$): Obviously

the small size distortions in individual time series accumulate in the panel as N increases.

A more serious problem of ignoring structural breaks is loss of power, as reported in Perron (1989) and Amsler and Lee (1995) for single time series. Our simulation results indicate that a similar pattern carries over to the panel unit root test. For example, in the ...rst panel, when T=25; N=100; the powers of IPS_N and LM_N are reported as 0:048 (size = 0:005 for the same T and N) and 0:050 (size = 0:004), respectively, while the power of LM_B for the same N and T is 0:473 (size = 0:058). However, the power of IPS_N and LM_N improves dramatically as T increases. For example in the ...rst panel, when T=100; N=10; the power of LM_N is 0.863 (size = 0:065).

It seems apparent that the low power of IPS_N and LM_N is largely a re‡ection of the downward size distortion. But, the power of LM_N is still lower than that of LM_B even after controlling for the size. When T=100; N=10 in the ...rst panel, the power of LM_B is 0.985 (size = 0:064), while the power of LM_N is 0.863 (size = 0:065).

On the other hand, the power of LM_B remains quite close to the corresponding ...gures reported in Table 1. For example, when T=N=25, the power of LM_B is 0:201 in the ...rst panel (size = 0:054 for the same T and N), and 0.204 in the second panel (size = 0:056): The corresponding ...gure in Table 1 is 0.207 (size = 0:054): This result bears a quite important message to practitioners: There is almost no power loss when someone mistakenly adopt LM_B (instead of LM_N or IPS_N) when there, in fact, are no structural breaks in the time series. Also, the power of LM_B in both panels remains more or less the same for corresponding N and T cases, which supports that the power of LM_B is not a ected by the value of $\frac{1}{2}$.

Another interesting ...gures are the sizes of LM_B for di¤erent combinations of the N=T ratios, since the asymptotic validity of LM_B requires that N=T should not diverge as N; T ! 1: This asymptotic result seems well re‡ected into ...nite sample. In the ...rst panel, for instance we obtained the size of LM_B; 0:083; 0:060; 0:062; 0:068, for T = 10 and N = 10; 25; 50; 100; respectively. The size of all other cases remains quite stable for di¤erent N=T ratios. The N=T ratio does not seem restrictive for applying LM_B to most practical situations.

³When the DF regression includes a dummy variable to control for the structural break, the asymptotic distribution of the resuting DF statistic depends on <code>.</code>. Therefore the IPS test requires the expected values and variances of the ADF t-statisites for every di¤erent value of <code>.</code> in the sample. This is quite an onerous job and was excluded from our simulation. However, we simulated the IPS-type statistic constructed from the DF regression including a break dummy variable, but using incorrectly the expected values and variances reported in IPS. The size is reported as 1.0 for all the sample cases studied in our simulation.

4.3. Experiment 3: Structural Breaks, Serial Correlations

In the third experiment we allow for serial correlations as well as a structural break in each time series. Two types of serial correlations are considered:

AR (1) :
$$"_{it} = 0.3"_{i;t_i} + e_{it};$$
 (4.3)

$$MA(1)$$
 : " $_{it} = e_{it} i \ 0:3e_{i;t_{i-1}};$ (4.4)

where e_{it} » iidN (0; 1): We maintain the same structural break pattern used in the second experiment in (4.2) with $_{si} = 0.5$ and $\pm_i = 5$ for all i. We simulate only the LM test based on the statistic $_{i}$ $_{LM}^{B}$ (p) in (3.21), where the number of augmented terms is ...xed at $p_i = 0$; 1; 2; 3; 4; for all i in the regression (3.19). When the necessary values of the expected value and variance for standardization are not provided in Table 1, they are interpolated. See Remark 3. The results are reported in Table 4.

Since N=T asymptotics is potentially an important issue and we are hoping that the test remains valid unless N=T diverges when the errors are serially correlated, special attention is paid to the movement of empirical sizes as N=T grows for di¤erent value of p.

The results for the AR (1) error are reported in the ...rst panel. When p=0 is selected, all the reported sizes are zero. The exect of selecting too small p accumulates as N grows. A similar pattern was reported for the IPS test in their paper. However, when the true model p=1 is selected, the empirical sizes of all N; T cases are reasonably close to the nominal 5%. For example, when T=25 and N=10;25;50;100; the empirical sizes are reported as 0.059, 0.064, 0.061, 0.058, respectively, which seems to support our conjecture that the test would remain valid in this case unless N=T diverges as both N and T+1. Similar results are obtained for the cases p=2;3 or 4. Any systematic pattern of size distortion for dixerent combinations of N=T is not observed.

The power of the test declines as larger p is selected, and the loss of power is steeper when T is relatively small. For example, when T=25 and N=100; the power of the test shrinks as; 0:357; 0:283; 0:207; 0:165 for p=1;2;3;4: But, when T=50 and N=10; the power of the test is 0.343, 0.299, 0.253, 0.208 for the same p.

The results for the MA(1) errors are reported in the second panel. There is no true modelling in this case. All we can hope for is that the selected p is

⁴IPS (1997, footnote 6) observed a very serious size distortion when the lag orders are selected by Akaike or Schwarz criterion. They conjectured that the information criteria, as is well known, tend to choose too few lags when T is small, and this exect accumulates in panel unit root test. A similar pattern is expected in the LM test. The data dependent method of selecting the lag order is an important issue, and it remains interesting to see the performance of the panel unit root test when the order of lags are chosen, for example, by the sequential method advocated by Ng and Perron (1995). But, in this paper we restrict ourselves to the study of ...xed p for all i, leaving the data dependent selection of p to future research. By ...xing p across individuals we could examine the exect of having too many or too few lagged terms.

large enough to ensure that the left over errors in the regression (3.19) are nearly uncorrelated so that the actual size of the test is reasonably close to the nominal size, and at the same time not too big so that the adverse exect on the power remains minimal. It is well known that the optimal p that serves this purpose depends on T as well as on the moving average parameter value. There is no asymptotic result available for the validity of any panel unit root tests when the errors follow moving average. Although the lack of theoretical underpinning makes it di¢cult to make a persuasive conjecture, it would be reasonable to expect that bigger p is needed when T is larger. Also there would be no reason to believe that the optimal p is associated with the size of N. Therefore, the problem again is which N=T condition will leave the test valid, given that the optimal p as a function of T is chosen. Although we do not have asymptotic results, we examine the exect of N on the size given that the some large enough p is selected for each time series.

Importance of the size of T in determination of the optimal p is clearly seen in the table. Using p=1 always leads to a size distortion. When T=25; using p=2 yields the size reasonably close to the nominal 5%. But, when T=50; p needs to be 3 or larger. The empirical size is tolerably close to the nominal size in all of the sample cases when p=3 or 4 is selected. A systematic exect of N on the size is rather obvious when too small p is selected. But, the exect quickly becomes negligible when p is selected properly. For instance, when T=50 and p=2; the size rises 0.081, 0.098, 0.110, 0.138 as N increases 10, 25, 50, 100. For the same N; T case but with p=3; the size is stable at 0.052, 0.055, 0.049, 0.050.

The power of the test decreases when the chosen p is larger than necessary. For example, when T=25 and N=50; the power drops from 0:160 to 0:066 as p changes from 2 to 3. When T=50 and N=10, the power decreases from 0:356 to 0:233 as p changes from 3 to 4.

5. Concluding Remarks

In this paper we developed a new unit root test using panel data based on the LM principle. The proposed test not only is robust to the presence of structural breaks, but is more powerful than the popular IPS test in the basic case where no structural breaks are involved. The former property in particular bears very important implication for empirical work since no other test has been developed yet which can handle the presence of structural shifts in a practical way. Further, as we reported in Section 4.2, since the LM test loses little power by controlling for spurious structural breaks when they do not exist, it would be a reasonable strategy to control for breaks even when they are only at a suspicious level.

We have focused on the case of one structural break in each time series in this paper, but extension to the case with multiple breaks should be straightforward. When there are more than one break in each time series, we have multiple dummy

variables in the data generation process (3.1), so that in (3.6)- (3.8). We cannot see any reason why the asymptotic results presented in this paper should not extend to the case of multiple breaks. But, it requires a more involved algebra, and is relegated to future research.

A. Appendix

In this appendix we show that

which we claimed in (3.17) and (3.18). We assume uniform integrability of L_T^B (\Box) and L_T : (See Remarks 1 and 3 in the text.) We drop subscript i for simplicity. The following lemmas will be used in the proof.

Lemma 1. Consider a regression:

$$y_t = x_t^- + \pm D_t + error; t = 1; 2; ...; T;$$
 (A.3)

where

$$D_t = \begin{cases} \frac{1}{2} & \text{for } t = \lambda; \\ 0 & \text{otherwise} \end{cases}$$

and x_t is 1£k vector. Let (Y; X; D) be the T£(k+2) data matrix and $(Y_x; X_x)$ be $(T_i 1)$ £ (k+1) matrix obtained after eliminating the ξ -th observations $(y_\xi; x_\xi)$ from (Y; X): Then,

$$X^{\emptyset}M_{(D)}X = X_{\pi}^{\emptyset}X_{\pi}; X^{\emptyset}M_{(D)}Y = X_{\pi}^{\emptyset}Y_{\pi};$$

where $M_{(\ell)}$ is the projection onto the null space of (ℓ) : The ...rst $\underset{:}{\wr}$ 1 and the last T $_i$ $\underset{:}{\wr}$ OLS residuals from the regression (A.3) is identical to the residuals obtained from regression of Y_{π} on X_{π} ; and the $\underset{:}{\wr}$ -th residual is zero.¥

Lemma 2. Let " $_t$ » iidN (0; ¾²); for t = 1; 2; ...; T; and " = (" $_1$; " $_2$; ...; " $_T$) 0 : Then

$$r = \frac{1}{\sqrt{1000}} = \frac{1}{3/4} + O_p i T_i^{1-2}$$
 (A.4)

Proof: The result follows from a Nagar-type expansion: $\frac{\mathbf{Q}_{\frac{T}{n_0 n}}}{\frac{T}{E(n_0 n) + [n_0 n]}} = \frac{\mathbf{Q}_{\frac{T}{E(n_0 n) + [n_0 n]}}}{\frac{T}{E(n_0 n) + [n_0 n]}} = \frac{\mathbf{Q}_{\frac{T}{E(n_0 n)} + [n_0 n]}}{\frac{T}{E(n_0 n)}} = \frac{\mathbf{Q}_{\frac{T}{E(n_0 n)}}}{\frac{T}{E(n_0 n)}} = \frac{\mathbf{Q}_{\frac{T}{E(n_$

From Lemma 1, $^{\circ}_{2}$ (suppressing subscripts i) in regression (3:8) is the average of Φ_{t} after eliminating Φ_{t+1} ; and Φ_{t+1}

$$\hat{z}_{2} = \frac{\mathbf{P}_{T}}{T_{i}} \underbrace{\psi_{t}_{i}} \underbrace{\psi_{T_{B}+1}}{T_{i}} = \frac{y_{T}_{i}}{T_{i}} \underbrace{y_{0}}{T_{i}} \underbrace{\psi_{T_{B}+1}}{T_{i}} = \frac{y_{T}_{i}}{T_{i}} \underbrace{y_{0}}{T_{i}} \underbrace{\psi_{T_{B}+1}}{T_{i}}; \tag{A.5}$$

$$\exists = \Phi y_{T_{B}+1} i \frac{y_{T} i y_{0} i \Phi y_{T_{B}+1}}{T i 1} = \frac{T \Phi y_{T_{B}+1} i (y_{T} i y_{0})}{T i 1} : (A.6)$$

Therefore, if we let
$$q_{t_{i} \ 1} = \begin{cases} & \textbf{i} & \textbf{i} \\ & \textbf{h} & \textbf{j} \\ & \textbf{h} & \textbf{T}(T_{i} \ 1) \ \textbf{i} & \frac{\textbf{c} y_{T_{B}+1}}{T_{i} \ 1} \ \textbf{i} & (\textbf{t}_{i} \ 1) \end{cases} \qquad \text{for } \textbf{t} \quad T_{B};$$

$$q_{t_{i} \ 1} = \frac{\textbf{y}_{T_{i}} \ y_{0}}{\textbf{h}^{T}(T_{i} \ 1)} \ \textbf{i} & \frac{\textbf{c} y_{T_{B}+1}}{T_{i} \ 1} \ \textbf{i} & (\textbf{t}_{i} \ 1) + \frac{\textbf{T} \textbf{c} y_{T_{B}+1} \ (y_{T_{i}} \ y_{0})}{T_{i} \ 1} \qquad \text{for } \textbf{t} \ \boldsymbol{J}_{B} + 1;$$
we have

we have

$$S_{t_{i} 1} = \hat{S}_{t_{i} 1 i} q_{t_{i} 1}$$
: (A.8)

Since L_T^B (s) is invariant numerically to dimerent values of \circ_1 ; \circ_2 and \pm under the null hypothesis, we assume, without loss of generality, $^{\circ}_{1} = ^{\circ}_{2} = \pm = 0$: Therefore, in the following, y_t follows a simple random walk with 0 initial value, and is denoted as

$$S_{t} = \underset{i=1}{\overset{\mathbf{X}}{\times}}; \tag{A.9}$$

where " $_{t}$ » iidN (0; $\frac{3}{4}$ ²): We then have, under the null hypothesis,

$$\hat{S}_{t_{i} 1} = S_{t_{i} 1 i} \frac{S_{T}}{T} (t_{i} 1); \qquad (A.10)$$

and

$$q_{t_{i} 1} = \begin{cases} \mathbf{8} & \mathbf{h} & \mathbf{i} \\ < & \mathbf{h}^{\frac{S_{T}}{T(T_{i} 1)}} \mathbf{i} & \frac{\mathbf{T}_{B+1}}{T_{i} 1} \mathbf{i} & (t_{i} 1) & \text{for } t T_{B}; \\ \vdots & \frac{S_{T}}{T(T_{i} 1)} \mathbf{i} & \frac{\mathbf{T}_{B+1}}{T_{i} 1} & (t_{i} 1) + \frac{\mathbf{T}^{T}_{T_{B+1} i} S_{T}}{T_{i} 1} & \text{for } t T_{B} + 1; \end{cases}$$
(A.12)

From (2.11) and (3.9), it is seen that

$$L_{T} = \frac{P_{\overline{J}}^{3} \hat{S}_{i 1}^{0} M_{(i_{T})}^{"}}{\hat{S}_{i 1}^{0} M_{(i_{T})}^{"} \hat{S}_{i 1}^{0}} + O_{p}^{i} T_{i 1}^{c}} + O_{p}^{i} T_{i 1}^{c}$$

$$= \frac{P_{\overline{J}}^{3} \hat{S}_{i 1}^{0} M_{(i_{T})}^{"}}{\hat{S}_{i 1}^{0} M_{(i_{T})}^{"}} + O_{p}^{i} T_{i 1}^{-c}; \qquad (A.13)$$

$$\hat{S}_{i 1}^{0} M_{(i_{T})} \hat{S}_{i 1}^{-c} ("^{0}")$$

and

$$L_{T}^{B}(s) = \frac{P_{T}^{3} S_{i,1}^{0} M_{(i_{T}; \Phi D)}^{0}}{S_{i,1}^{0} M_{(i_{T}; \Phi D)}^{0} S_{i,1}^{0}} + O_{p}^{i} T^{i,1}^{0}$$

$$= \frac{P_{T}^{3} S_{i,1}^{0} M_{(i_{T}; \Phi D)}^{0} M_{(i_{T}; \Phi D)}^{0}}{P_{T}^{3} S_{i,1}^{0} M_{(i_{T}; \Phi D)}^{0}} + O_{p}^{i} T^{i,1}^{0}$$

$$= \frac{P_{T}^{3} M_{(i_{T}; \Phi D)}^{0} S_{i,1}^{0} M_{(i_{T}; \Phi D)}^{0}}{S_{i,1}^{0} M_{(i_{T}; \Phi D)}^{0} S_{i,1}^{0} M_{(i_{T}; \Phi D)}^{0}}$$
(A.14)

De...ne

$$a_{T} = \hat{S}_{i 1}^{\emptyset} M_{(i_{T})} \hat{S}_{i 1 i} \quad \hat{S}_{i 1}^{\emptyset} M_{(i_{T}; \Phi D)} \hat{S}_{i 1}; \quad b_{T} = \hat{S}_{i 1}^{\emptyset} M_{(i_{T})} "; \quad \hat{S}_{i 1}^{\emptyset} M_{(i_{T}; \Phi D)} "; \quad (A.15)$$

and

$$A_{T} = \frac{a_{T}}{\hat{S}_{i}^{0} M_{(i_{T})} \hat{S}_{i}^{1}}; B_{T} = \frac{b_{T}}{\hat{S}_{i}^{0} M_{(i_{T})} \hat{S}_{i}^{1} ("^{0}")}$$
(A.16)

Dividing both the numerator and the denominator of L_T^B () by $\hat{S}_{i-1}^{I}M_{(i_T)}\hat{S}_{i-1}$ ("""); we have

$$O = \frac{1}{P_{T}^{3} \hat{S}_{i}^{0} \cdot M_{(i_{T})}^{"}} i P_{T}^{1} B_{T}^{1} A$$

$$L_{T}^{B}(s) = \frac{P_{i_{1}}^{3} M_{(i_{T})}^{0} \hat{S}_{i_{1}}^{0} M_{(i_{T})}^{0} \hat{S}_{i_{1}}^{0} M_{(i_{T})}^{0}}{(1_{1} A_{T})} + O_{p}^{i_{1}} T_{i_{1}}^{i_{1}} + O_{p}^{i_{1}} T_{i_{1}}^{i_{2}}$$

$$= L_{T} + A_{T} + \frac{A_{T}^{2}}{1_{1} A_{T}} i P_{T}^{T} B_{T} + \frac{A_{T}}{1_{1} A_{T}} + O_{p}^{i_{1}} T_{i_{1}}^{i_{2}} \hat{S}_{I}^{i_{2}} + O_{p}^{i_{1}} \hat{S}_{I}^{i_{2}} \hat{S}_{I}^{i_{2}} + O_{p}^{i_{1}} \hat{S}_{I}^{i_{2}} \hat$$

After some algebra (available from the authors upon request), we obtain

$$a_{T} = 2^{"}_{T_{B}+1} \quad i \quad \frac{1}{T} \quad X \quad (t_{i} \quad 1) S_{t_{i}} \quad + \quad \frac{\mu_{1}}{2} \quad X \quad S_{t_{i}} \quad + \quad \frac{\mu_{1}}{3} \quad + \quad \frac{1}{3} \quad + \quad \frac{1}{2} \quad T S_{T} \quad + O_{p} (T) ;$$
(A.18)

and

$$b_{T} = "_{T_{B}+1} \frac{1}{2T} X_{t=1} t"_{t} + \frac{1}{T} X_{t=1} S_{t_{i} 1} + O_{p} (1);$$
(A.19)

where $S_{t_i~1}$ is the partial sum process de...ned in (A.9), and $\Box=\frac{T_B}{T}$: It now is obvious that $a_T=O_p$, $b_T=O_p$, and $T^{1=2}$; and

$$A_T = O_p(T^{i^{1=2}}) \text{ and } P_{\overline{T}B_T} = O_p(T^{i^{1=2}}):$$
 (A.20)

Therefore, it is seen from (A.17) that

$$L_{T}^{B}(_{s})_{i} L_{T} = \frac{1}{2}L_{T}A_{T}_{i} \stackrel{P}{T}B_{T} + O_{p}^{i}T_{i}^{1}^{c};$$
 (A.21)

which is $O_p(T^{\frac{1}{1}-2})$.

Now we prove the claim in (A.2). From Assumption 3.1 of the uniform integrability of $L_T^B\left(\ _{\text{\tiny s}}\right)$ and L_T we have

$$E_{L_{T}^{B}(s)_{i}}^{\mathbf{f}} L_{T}^{\mathbf{g}} = \frac{1}{2} E(L_{T}A_{T})_{i}^{\mathbf{p}} \overline{T} E(B_{T}) + O_{T_{i}^{-1}}^{\mathbf{f}}$$
: (A.22)

The result follows if we show $E(L_TA_T) = O(T^{\frac{1}{1}})$ and $E(C_T) = O^{\frac{1}{1}}T^{\frac{3}{1}}$: Combining (A.16) and (A.18) and applying Lemma 2, we have:

$$\frac{2^{"}_{T_{B}+1}\hat{S}^{\emptyset}_{i} M_{(i_{T})}^{"} \overset{\textbf{h}}{i} \overset{\textbf{P}}{\overset{\textbf{T}}{T}} \overset{\textbf{h}}{\overset{\textbf{T}}{T}} \overset{\textbf{p}}{\overset{\textbf{T}}{T}} (t_{i} \overset{\textbf{1}}{\underline{1}}) S_{t_{i}} \overset{\textbf{i}}{\underline{1}} + \overset{\textbf{i}}{\overset{\textbf{1}}{\underline{2}}} \overset{\textbf{p}}{\overset{\textbf{T}}{T}} S_{t_{i}} \overset{\textbf{i}}{\underline{1}} + \overset{\textbf{i}}{\overset{\textbf{1}}{\underline{3}}} + \overset{\textbf{1}}{\overset{\textbf{2}}{\underline{2}}} \overset{\textbf{p}}{\overset{\textbf{T}}{T}} \overset{\textbf{i}}{T} \overset{\textbf{p}}{\overset{\textbf{T}}{T}} \overset{\textbf{p}}{\overset{\textbf{p}}{T}} + O_{p} \overset{\textbf{i}}{T} \overset{\textbf{1}}{\overset{\textbf{p}}{T}} \overset{\textbf{p}}{\overset{\textbf{p}}{T}} \overset{\textbf{p}}{T}} \overset{\textbf{p}}{\overset{\textbf{p}}{T}} \overset{\textbf{p}}{\overset{\textbf{p}}{T}} \overset{\textbf{p}}{T}} \overset{\textbf{p}}{\overset{\textbf{p}}{T}} \overset{\textbf{p}}{T}} \overset{\textbf{p}}{\overset{\textbf{p}}{T}} \overset{\textbf{p}}{T}} \overset{\textbf{p}}{\overset{\textbf{p}}{T}} \overset{\textbf{p}}{T}} \overset{\textbf{p}}{T}} \overset{\textbf{p}}{\overset{\textbf{p}}{T}} \overset{\textbf{p}}{T}} \overset{\textbf{p}}{T}} \overset{\textbf{p}}{T} \overset{\textbf{p}}{T}} \overset{\textbf{p}}{T} \overset{\textbf{p}}{T} \overset{\textbf{p}}{T}} \overset{\textbf{p}}{T} \overset{\textbf{p}}{T}} \overset{\textbf{p}}{T}} \overset{\textbf{p}}{T}} \overset{\textbf{p}}{T} \overset{\textbf{p}}{T}} \overset{\textbf{p}}{T}} \overset{\textbf{p}}{T} \overset{\textbf{p}}{T}} \overset{\textbf{p}}{T} \overset{\textbf{p}}{T} \overset{\textbf{p}}{T}} \overset{\textbf{p}}{T} \overset{\textbf{p}}{T}} \overset{\textbf{p}}{T}} \overset{\textbf{p}}{T} \overset{\textbf{p}}{T}} \overset{\textbf{p}}{T} \overset{\textbf{p}}{T}} \overset{\textbf{p}}{T} \overset{\textbf{p}}{T}} \overset{\textbf{p}}{T}} \overset{\textbf{p}}{T} \overset{\textbf{p}}{T} \overset{\textbf{p}}{T}} \overset{\textbf{p}}{T}} \overset{\textbf{p}}{T} \overset{\textbf{p}}$$

It is straightforward to see that

$$\overset{\hat{S}_{i}^{0}}{X} \underset{t=1}{N} S_{t_{i} 1 i}^{2} = \underbrace{X}_{t=1} \underbrace{X}_{t=1} \underbrace{X}_{t=1} \underbrace{X}_{t=1} \underbrace{X}_{t=1} \underbrace{X}_{t=1} \underbrace{X}_{t_{i} 1} \underbrace{X}_{t=1} \underbrace{X}_{t=1} \underbrace{X}_{t=1} \underbrace{X}_{t=1} \underbrace{X}_{t=1} \underbrace{X}_{t_{i} 1} \underbrace{X}_{t=1} \underbrace{X}_{t_{i} 1} \underbrace{X}_{t=1} \underbrace{X}_{t_{i} 1} \underbrace{X}_{t=1} \underbrace{X}_{t_{i} 1} \underbrace{X}_{t_{i$$

Let $\hat{S}_{i-1}^0 M_{(i_T)} \hat{S}_{i-1} = V_{1T} + V_{2T}$; where V_{1T} is the sum of all the terms that include " T_{B+1} , and V_{2T} is the sum of the rest of the terms. Thus, no " T_{B+1} is associated with V_{2T} . Then, it is straightforward to see that $V_{1T} = O_p^{-1} T^{3-2}$ and $V_{2T} = O_p^{-1} (T^2)$: For example, the term associated with " T_{B+1} in the leading term, $T_{B+1}^T = S_{t_{i-1}}^2$; is the squared terms of order $T_{B}^T = S_{t_{i-1}}^T = S_{t_{i-1}}^$

We de...ne the numerator of (A.23) to be $2"_{T_B+1}U_T$; and divide both the numerator and the denominator of (A.23) by $(V_{2T})^{3=2}$ to have

$$L_{T}A_{T} = \frac{2"_{T_{B}+1}U_{T} = (V_{2T})^{3=2}}{\sqrt[3]{4}(1 + V_{1T} = V_{2T})^{3=2}} = \frac{2"_{T_{B}+1}U_{T}}{(V_{2T})^{3=2}} + O_{p} i_{T_{i}}^{\dagger} :$$
 (A.25)

Now let $U_T = U_{1T} + U_{2T}$; where U_{1T} is the sum of the terms associated with " T_{B+1} and T_{2T} is the sum of the rest. Therefore, we have;

$$E(L_{T}A_{T}) = 2E \frac{"_{T_{B}+1}U_{1T}}{(V_{2T})^{3=2}} + 2E \frac{"_{T_{B}+1}U_{2T}}{(V_{2T})^{3=2}} + O^{i}T^{i}^{1}:$$
(A.26)

From the normality assumption, $U_{2T} = (V_{2T})^{3=2}$ is independent of " $_{T_B+1}$ so that the second term of the right hand side vanishes. Also, it is straightforward to show that $U_{1T} = O_p(T_i^{-2})$: We therefore have " $_{T_B+1}U_{1T} = (V_{2T})^{3=2} = O_p(T^{i-1})$; and $E_{T_B+1}U_{1T} = (V_{2T})^{3=2} = O(T^{i-1})$:

 $E(B_T) = O^{i}T^{i}^{3=2}$ is proved similarly. From (A.16) and (A.19), we have:

$$B_{T} = \frac{ \frac{1}{T_{B+1}} \frac{1}{2T} \frac{P_{T}}{t=1} t''_{t} + \frac{1}{T} \frac{P_{T}}{t=1} S_{t_{i} 1}}{\hat{S}_{i}^{0} 1 M_{(i_{T})} \hat{S}_{i} 1} + O_{p} \mathbf{i}_{T^{i}}^{3=2} \mathbf{c}_{T^{i}}^{1}$$

$$= \frac{ \frac{1}{T_{B+1}} \frac{1}{2} \frac{P_{T}}{t=1} t''_{t} + \frac{P_{T}}{t=1} S_{t_{i} 1}}{T^{3} \hat{S}_{i}^{0} 1 M_{(i_{T})} \hat{S}_{i} 1} + O_{p} \mathbf{i}_{T^{i}}^{3=2} \mathbf{c}_{T^{i}}^{1}$$

$$= \frac{ \frac{1}{T_{B+1}} \frac{1}{2} \frac{P_{T}}{t=1} t''_{t} + \frac{P_{T}}{t=1} S_{t_{i} 1}}{P_{T^{i}}^{3} V_{2T}} + O_{p} \mathbf{i}_{T^{i}}^{3=2} \mathbf{c}_{T^{i}}^{1}$$

$$= \frac{(A.28)}{P_{T^{i}}^{3} V_{2T}}$$

The second equality follows from Lemma 2, and the third equality is obtained by dividing the numerator and the denominator by $\overline{T^3V_{2T}}$: Let

$$W_T = W_{1T} + W_{2T} = \frac{1}{2} \frac{X}{t_{t=1}} t_{t_t} + \frac{X}{t_{t_t}} S_{t_{t_t}};$$
 (A.29)

where W_{1T} is the sum of the terms associated with " $_{T_{B}+1}$ and W_{2T} $\stackrel{j}{D}$ $\stackrel{j}{S}$ the sum of the rest of the terms. From the independence of " $_{T_{B}+1}$ and W_{2T} $\stackrel{j}{D}$ $\stackrel{j}{T}$ $\stackrel{j}{V}$ $\stackrel{j}{V}$ $\stackrel{j}{V}$ we have

$$E(B_{T}) = E^{\frac{"}{T_{B}+1}} \underbrace{P^{W_{1T}}_{\overline{T^{3}V_{2T}}}}^{(W_{1T}+W_{2T})} + O^{\mathbf{i}} T^{i}^{3=2} = E^{\frac{"}{T_{B}+1}W_{1T}}_{\overline{T^{3}V_{2T}}} + O^{\mathbf{i}} T^{i}^{3=2}$$
(A.30)

But, " $_{T_B+1}W_{1T}=Q_p(T)$; and " $_{T_B+1}W_{1T}=\stackrel{\textstyle p}{\overline{T^3V_{2T}}}=O_p^{i}T^{i}^{3=2}$; so that we have E $(B_T)=O^{i}T^{i}^{3=2}$; which completes the proof.

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Addendum to:

"LM Unit Root Test with Panel Data; A Test Robust to Structural Changes" by Kyung So Im and Junsoo Lee

In this note we show the algebra for deriving a_T and b_T in (A.18) and (A.19) of the Appendix. Note that

$$\hat{S}_{i}^{0} M_{(i_{T})} \hat{S}_{i}^{1} = X S_{t_{i}}^{2} i \frac{1}{T} X S_{t_{i}}^{1} : \qquad (1)$$

We also have from Lemma 1

$$S_{i 1}^{0} M_{(i_{T}; \Phi D)} S_{i 1} = \begin{array}{c} \mathbf{X} \\ S_{t_{i} 1}^{2} i \end{array} S_{T_{B} i}^{2} \frac{1}{T_{i} 1} \begin{array}{c} \mathbf{X} \\ \mathbf{X} \\ \mathbf{X} \end{array} S_{t_{i} 1 i} S_{T_{B}} \\ = \begin{array}{c} \mathbf{X} \\ \mathbf$$

Plugging the results of (1) and (2) into a_T in (A.15) of the Appendix yields:

and
$$\frac{T}{T_{i} \cdot 1} \stackrel{\text{3}}{\hat{S}}_{T_B \cdot i} \stackrel{\text{7}}{q}_{T_B} = O_p(T)$$
: Therefore, we have
$$\stackrel{\text{7}}{\mathbf{X}} \stackrel{\text{7}}{\mathbf{X}} = 0 \stackrel{\text{7}}{\mathbf{X}} \stackrel$$

which is what we have in (A.18) in the Appendix. Following a visual inspection, the order of a_T is O_p $T^{3=2}$; so that $A_T = O_p$ $T^{i-1=2}$:

Now we derive the expression in (A.19). Note that
$$S_{i-1}^{0}M_{(i_{T}:\Phi D)}" = \begin{array}{c} \mathbf{X} \\ \mathbf{S}_{i-1}^{0}M_{(i_{T}:\Phi D)}" = \\ \mathbf{X} \\ \mathbf{S}_{i-1}^{0}\mathbf{I} \\ \mathbf{X} \\$$

and

Therefore,

O_p (1): Therefore,

$$\frac{1}{T_{i}} \frac{\mathbf{X}}{1} q_{t_{i}} q_{t_{i}} \mathbf{X} = \frac{1}{T_{i}} \frac{\mathbf{S}_{T}}{T(T_{i})} i \frac{\mathbf{T}_{B+1}}{T_{i}} \mathbf{X} (t_{i}) + (1_{i}) \frac{\mathbf{T}_{B+1}}{T_{i}} \mathbf{S}_{T} \mathbf{X} = \frac{\mathbf{\mu}_{1}}{2} i \mathbf{X} \mathbf{T}_{B+1} \mathbf{X} \mathbf{X} + O_{p}(1);$$

and

$$\frac{T}{T_{i}} S_{T_{B}} T_{B+1} = \hat{S}_{T_{B}} T_{B+1} + O_{p} (1)$$

$$= S_{T_{B}} T_{B+1} + S_{T} T_{B+1} + O_{p} (1):$$

Combining these results, we obtain

 $\frac{Table~1}{Mean~and~Variance~of~\textbf{\textit{L}}_{T}(p)}$

T	p=0	p=I	p=2	p=3	p=4	p=5	<i>p</i> =6	p=7	p=8
	Mean Var.								
	-2.012 0.518	-1.997 0.662	-1.761 0.708	-1.751 1.082					
	-2.009 0.493	-1.994 0.604	-1.781 0.623	-1.765 0.887	-1.590 1.070				
	-2.003 0.476	-1.991 0.561	-1.795 0.572	-1.776 0.763	-1.611 0.885	-1.604 1.218			
	-2.002 0.464	-1.990 0.535	-1.810 0.537	-1.790 0.686	-1.635 0.779	-1.620 1.018	-1.489 1.188		
	-1.999 0.451	-1.990 0.511	-1.823 0.509	-1.803 0.629	-1.655 0.702	-1.638 0.898	-1.511 1.016	-1.503 1.317	
15	-1.998 0.441	-1.988 0.490	-1.833 0.490	-1.814 0.591	-1.675 0.648	-1.657 0.806	-1.534 0.901	-1.521 1.123	-1.412 1.292
16	-1.995 0.435	-1.987 0.480	-1.842 0.470	-1.825 0.557	-1.693 0.605	-1.676 0.737	-1.559 0.821	-1.545 0.998	-1.439 1.116
	-1.994 0.428	-1.985 0.464	-1.851 0.457	-1.834 0.533	-1.709 0.572	-1.689 0.684	-1.577 0.755	-1.559 0.904	-1.458 0.996
	-1.992 0.420	-1.985 0.455	-1.858 0.444	-1.843 0.512	-1.725 0.543	-1.705 0.642	-1.598 0.704	-1.580 0.833	-1.481 0.909
	-1.992 0.417	-1.984 0.446	-1.865 0.438	-1.851 0.498	-1.738 0.521	-1.720 0.607	-1.617 0.664	-1.599 0.779	-1.503 0.844
	-1.992 0.417	-1.982 0.437	-1.870 0.427	-1.858 0.481	-1.750 0.502	-1.733 0.580	-1.633 0.629	-1.615 0.731	-1.524 0.793
20	-1.990 0.411	-1.962 0.437	-1.870 0.427	-1.030 0.401	-1.730 0.302	-1.733 0.380	-1.033 0.029	-1.013 0.731	-1.324 0.793
21	-1.988 0.407	-1.983 0.429	-1.875 0.418	-1.864 0.468	-1.760 0.487	-1.745 0.558	-1.649 0.598	-1.632 0.691	-1.543 0.747
22	-1.987 0.402	-1.982 0.424	-1.880 0.413	-1.869 0.456	-1.773 0.473	-1.757 0.536	-1.666 0.574	-1.650 0.657	-1.563 0.706
23	-1.988 0.399	-1.982 0.418	-1.884 0.408	-1.875 0.449	-1.781 0.461	-1.766 0.520	-1.678 0.552	-1.661 0.626	-1.579 0.675
24	-1.987 0.397	-1.982 0.416	-1.889 0.403	-1.879 0.441	-1.789 0.453	-1.775 0.505	-1.690 0.534	-1.675 0.601	-1.595 0.645
25	-1.985 0.393	-1.980 0.410	-1.892 0.399	-1.883 0.434	-1.798 0.445	-1.785 0.494	-1.702 0.520	-1.687 0.581	-1.609 0.620
2.5	1 005 0 201	1 000 0 106	1 005 0 205	1 007 0 126	1 000 0 100	1.701 0.470	1.712 0.504	1 607 0 561	1 (21 0 507
	-1.985 0.391	-1.980 0.406	-1.895 0.395	-1.887 0.426	-1.803 0.433	-1.791 0.478	-1.712 0.504	-1.697 0.561	-1.621 0.597
	-1.985 0.389	-1.980 0.402	-1.898 0.391	-1.890 0.421	-1.810 0.430	-1.799 0.470	-1.722 0.489	-1.709 0.542	-1.636 0.576
	-1.984 0.386	-1.980 0.399	-1.901 0.387	-1.894 0.415	-1.818 0.420	-1.806 0.458	-1.732 0.479	-1.718 0.528	-1.646 0.557
	-1.983 0.384	-1.977 0.396	-1.902 0.386	-1.894 0.410	-1.820 0.415	-1.809 0.450	-1.738 0.469	-1.726 0.515	-1.657 0.544
30	-1.983 0.381	-1.978 0.393	-1.906 0.384	-1.900 0.408	-1.828 0.411	-1.818 0.443	-1.748 0.460	-1.735 0.502	-1.667 0.528
31	-1.982 0.381	-1.978 0.391	-1.908 0.382	-1.902 0.403	-1.834 0.407	-1.824 0.437	-1.758 0.453	-1.746 0.494	-1.681 0.516
	-1.982 0.379	-1.979 0.390	-1.911 0.379	-1.905 0.400	-1.838 0.402	-1.829 0.430	-1.764 0.443	-1.753 0.481	-1.689 0.504
	-1.981 0.376	-1.977 0.387	-1.912 0.377	-1.906 0.396	-1.841 0.398	-1.833 0.426	-1.770 0.440	-1.759 0.474	-1.697 0.494
	-1.980 0.375	-1.977 0.386	-1.913 0.375	-1.909 0.395	-1.845 0.394	-1.836 0.419	-1.776 0.432	-1.766 0.464	-1.706 0.485
	-1.981 0.374	-1.978 0.383	-1.916 0.373	-1.911 0.392	-1.849 0.392	-1.841 0.417	-1.782 0.427	-1.771 0.459	-1.712 0.475
55	1.701 0.374	1.770 0.303	1.710 0.373	1.711 0.372	1.047 0.372	1.041 0.41/	1.702 0.727	1.771 0.737	1./12 0.4/3

Table 1 Continued

T	p=0	p=1	p=2	p=3	p=4	p=5	<i>p</i> =6	p=7	p=8
	Mean Var.	Mean Var.	Mean Var.	Mean Var.	Mean Var.	Mean Var.	Mean Var.	Mean Var.	Mean Var.
36	-1.980 0.373	-1.977 0.381	-1.918 0.373	-1.913 0.389	-1.853 0.391	-1.845 0.414	-1.787 0.421	-1.777 0.452	-1.719 0.469
	-1.979 0.371	-1.977 0.381	-1.919 0.372	-1.914 0.388	-1.856 0.387	-1.849 0.409	-1.793 0.420	-1.783 0.447	-1.728 0.463
	-1.980 0.371	-1.977 0.379	-1.919 0.369	-1.915 0.383	-1.858 0.384	-1.852 0.405	-1.797 0.412	-1.788 0.439	-1.734 0.454
39	-1.979 0.370	-1.977 0.377	-1.922 0.368	-1.918 0.382	-1.863 0.382	-1.856 0.403	-1.803 0.408	-1.795 0.434	-1.742 0.447
40	-1.978 0.368	-1.974 0.375	-1.921 0.367	-1.917 0.381	-1.864 0.380	-1.858 0.399	-1.806 0.405	-1.798 0.429	-1.747 0.441
41	-1.979 0.367	-1.976 0.375	-1.924 0.365	-1.920 0.378	-1.868 0.377	-1.862 0.395	-1.810 0.401	-1.802 0.425	-1.752 0.436
	-1.979 0.367	-1.977 0.374	-1.926 0.364	-1.921 0.376	-1.871 0.376	-1.865 0.392	-1.815 0.398	-1.807 0.419	-1.758 0.430
43	-1.979 0.366	-1.977 0.373	-1.927 0.364	-1.924 0.377	-1.874 0.375	-1.868 0.391	-1.820 0.396	-1.812 0.417	-1.764 0.428
44	-1.978 0.364	-1.975 0.371	-1.927 0.362	-1.923 0.374	-1.875 0.371	-1.870 0.388	-1.822 0.392	-1.815 0.412	-1.768 0.422
45	-1.977 0.363	-1.975 0.370	-1.928 0.361	-1.924 0.372	-1.877 0.370	-1.872 0.386	-1.825 0.390	-1.818 0.408	-1.772 0.418
46	-1.978 0.364	-1.975 0.369	-1.928 0.360	-1.925 0.371	-1.879 0.369	-1.874 0.384	-1.828 0.388	-1.821 0.407	-1.776 0.415
	-1.977 0.362	-1.974 0.368	-1.928 0.359	-1.925 0.370	-1.880 0.368	-1.875 0.381	-1.831 0.384	-1.824 0.403	-1.780 0.411
	-1.977 0.362	-1.974 0.367	-1.930 0.360	-1.927 0.369	-1.882 0.365	-1.878 0.380	-1.835 0.382	-1.830 0.399	-1.787 0.407
	-1.978 0.361	-1.976 0.368	-1.933 0.360	-1.929 0.369	-1.886 0.366	-1.881 0.379	-1.838 0.381	-1.832 0.398	-1.789 0.405
	-1.976 0.360	-1.974 0.365	-1.932 0.357	-1.930 0.366	-1.888 0.363	-1.884 0.377	-1.841 0.379	-1.835 0.394	-1.794 0.402
55	-1.976 0.358	-1.974 0.363	-1.936 0.355	-1.933 0.363	-1.894 0.360	-1.891 0.371	-1.854 0.371	-1.850 0.385	-1.812 0.390
	-1.975 0.355	-1.974 0.359	-1.939 0.353	-1.937 0.360	-1.902 0.357	-1.899 0.366	-1.864 0.365	-1.859 0.377	-1.824 0.379
	-1.975 0.352	-1.973 0.356	-1.941 0.351	-1.939 0.356	-1.907 0.351	-1.904 0.360	-1.872 0.359	-1.868 0.370	-1.835 0.372
	-1.974 0.351	-1.972 0.355	-1.943 0.349	-1.941 0.353	-1.912 0.349	-1.909 0.357	-1.880 0.357	-1.876 0.366	-1.846 0.367
75	-1.974 0.350	-1.973 0.353	-1.945 0.347	-1.943 0.351	-1.914 0.347	-1.913 0.354	-1.885 0.353	-1.882 0.361	-1.854 0.361
80	-1.973 0.348	-1.971 0.351	-1.945 0.347	-1.944 0.350	-1.918 0.347	-1.916 0.352	-1.890 0.350	-1.887 0.358	-1.861 0.358
	-1.973 0.347	-1.972 0.349	-1.947 0.344	-1.946 0.347	-1.921 0.343	-1.920 0.349	-1.895 0.347	-1.892 0.354	-1.869 0.355
	-1.973 0.348	-1.971 0.349	-1.949 0.344	-1.948 0.348	-1.925 0.345	-1.923 0.349	-1.900 0.348	-1.898 0.352	-1.875 0.352
	-1.973 0.346	-1.971 0.347	-1.949 0.342	-1.948 0.345	-1.926 0.342	-1.925 0.346	-1.904 0.345	-1.902 0.350	-1.880 0.349
	0 -1.973 0.346	-1.972 0.347	-1.951 0.343	-1.950 0.346	-1.929 0.343	-1.928 0.347	-1.908 0.346	-1.905 0.350	-1.885 0.350
200	0 -1.970 0.337	-1.969 0.337	-1.960 0.336	-1.959 0.337	-1.949 0.334	-1.949 0.335	-1.938 0.333	-1.938 0.336	-1.927 0.334

See Definition 2 and Remark 3 in the text.

Table 2
Size and Power of Panel Unit Root Tests
(Experiment 1: No Structural Breaks, No Serial Correlation)

		T = 10		T = 25		T = 50		T = 100	
		Size	Power	Size	Power	Size	Power	Size	Power
<u>N=10</u>	LM	0.065	0.086	0.068	0.149	0.068	0.484	0.051	0.990
	IPS	0.063	0.062	0.062	0.124	0.059	0.357	0.050	0.961
<u>N=25</u>	LM	0.064	0.080	0.054	0.207	0.058	0.802	0.060	1.000
	IPS	0.051	0.066	0.051	0.162	0.059	0.622	0.055	1.000
<u>N=50</u>	LM	0.050	0.072	0.056	0.325	0.053	0.974	0.058	1.000
	IPS	0.046	0.071	0.051	0.261	0.047	0.899	0.057	1.000
<u>N=100</u>	LM	0.051	0.083	0.060	0.518	0.052	1.000	0.042	1.000
	IPS	0.051	0.072	0.063	0.415	0.054	0.997	0.049	1.000

Table 3
Size and Power of Panel Unit Root Tests
(Experiment 2: Structural Breaks, No Serial Correlation)

		T = 10		T = 25		$\underline{T} =$	<u>50</u>	<u>T</u> =	T = 100	
-		Size	Power	Size	Power	Size	Power	Size	Power	
				1 =	= 0.5					
$\underline{I} = 0.5$										
<u>N=10</u>	LM_N	0.008	0.008	0.033	0.055	0.049	0.226	0.065	0.863	
	IPS_N	0.001	0.002	0.017	0.038	0.033	0.144	0.047	0.745	
	LM_B	0.083	0.094	0.074	0.160	0.072	0.460	0.064	0.985	
<u>N=25</u>	LM_N	0.001	0.002	0.021	0.051	0.042	0.379	0.067	0.997	
	IPS_N	0.001	0.001	0.016	0.040	0.033	0.272	0.044	0.989	
	LM_B	0.060	0.074	0.054	0.201	0.067	0.775	0.075	1.000	
N-50	IMN	0.001	0.001	0.013	0.050	0.036	0.622	0.043	1.000	
<u>N=50</u>	LM_N IPS_N	0.001	0.001	0.013	0.030	0.030	0.622	0.043	1.000	
	LM_B	0.062	0.086	0.064	0.043	0.023	0.968	0.059	1.000	
	LM_D	0.002	0.000	0.004	0.277	0.000	0.700	0.037	1.000	
<u>N=100</u>	LM_N	0.000	0.000	0.006	0.050	0.028	0.870	0.043	1.000	
	IPS_N	0.000	0.000	0.005	0.048	0.017	0.763	0.036	1.000	
	LM_B	0.068	0.106	0.058	0.473	0.059	1.000	0.050	1.000	
				<u>1 =</u>	= <i>0.3</i>					
<u>N=10</u>	LM_N	0.006	0.007	0.029	0.046	0.057	0.199	0.056	0.851	
1, 10	IPS_N	0.000	0.000	0.006	0.007	0.025	0.046	0.035	0.534	
	LM_B	0.070	0.081	0.070	0.144	0.068	0.452	0.061	0.986	
<u>N=25</u>	LM_N	0.001	0.000	0.019	0.048	0.046	0.353	0.046	0.998	
1, 25	IPS_N	0.000	0.000	0.002	0.003	0.009	0.058	0.016	0.877	
	LM_B	0.068	0.085	0.056	0.204	0.060	0.781	0.072	1.000	
<u>N=50</u>	LM_N	0.000	0.000	0.009	0.032	0.033	0.536	0.048	1.000	
	IPS_N	0.000	0.000	0.000	0.000	0.003	0.077	0.017	0.995	
	LM_B	0.061	0.087	0.056	0.291	0.056	0.961	0.060	1.000	
<u>N=100</u>	LM_N	0.000	0.000	0.004	0.028	0.024	0.810	0.040	1.000	
	IPS_N	0.000	0.000	0.000	0.000	0.000	0.085	0.007	1.000	
	LM_B	0.070	0.104	0.051	0.459	0.054	1.000	0.050	1.000	

See Section 4.2 for the definition of LM_N, IPS_N and LM_B.

Table 4
Size and Power of Panel LM Unit Root Tests
(Experiment 3: Structural Breaks, Serial Correlation)

T	N	$\frac{p=0}{\text{Size Power}}$	$\frac{p=1}{\text{Size Power}}$	$\frac{p=2}{\text{Size Power}}$	$\frac{p=3}{\text{Size Power}}$	$\frac{p=4}{\text{Size Power}}$					
_			3120 1001	2120 1001	2120 101101						
	AR(1) Error: $r = 0.3$										
25	10	$0.000 \ 0.000$	0.059 0.111	0.061 0.105	0.064 0.098	0.070 0.088					
	25	$0.000 \ 0.000$	0.064 0.163	0.086 0.160	0.075 0.135	0.070 0.110					
	50	$0.000 \ 0.000$	0.061 0.229	0.075 0.180	0.061 0.144	0.075 0.130					
	100	$0.000 \ 0.000$	0.058 0.357	0.077 0.283	0.072 0.207	0.073 0.165					
50	10	$0.000 \ 0.000$	0.061 0.343	0.067 0.299	0.065 0.253	0.059 0.208					
	25	$0.000 \ 0.000$	0.065 0.632	0.079 0.540	0.073 0.462	0.073 0.361					
	50	$0.000 \ 0.000$	0.063 0.883	0.068 0.810	0.069 0.703	0.069 0.584					
	100	$0.000 \ 0.000$	0.066 0.993	0.073 0.972	0.070 0.916	0.059 0.823					
100	10	0.000 0.024	0.066 0.954	0.076 0.913	0.066 0.859	0.067 0.808					
	25	0.000 0.027	0.060 1.000	0.061 1.000	0.061 0.998	0.059 0.991					
	50	0.000 0.032	0.044 1.000	0.050 1.000	0.047 1.000	0.056 1.000					
	100	0.000 0.044	0.063 1.000	0.070 1.000	0.069 1.000	0.076 1.000					
			MA(1) E	Error: $q = -0.3$							
			MA(1)	$\underline{\mathbf{q}} = -0.5$							
25	10	0.880 0.961	0.165 0.267	0.063 0.106	0.043 0.073	0.042 0.052					
	25	1.000 1.000	0.237 0.441	0.059 0.132	0.040 0.063	0.030 0.051					
	50	1.000 1.000	0.334 0.656	0.052 0.160	0.024 0.066	0.021 0.053					
	100	1.000 1.000	0.540 0.890	0.058 0.237	0.021 0.078	0.019 0.053					
50	10	0.974 1.000	0.232 0.705	0.081 0.356	0.052 0.233	0.044 0.186					
	25	1.000 1.000	0.410 0.965	0.098 0.658	0.055 0.431	0.042 0.330					
	50	1.000 1.000	0.620 1.000	0.110 0.884	0.049 0.677	0.042 0.493					
	100	1.000 1.000	0.859 1.000	0.138 0.994	$0.050\ 0.898$	0.029 0.732					
100	10	0.992 1.000	0.304 1.000	0.096 0.967	0.065 0.890	0.054 0.810					
	25	1.000 1.000	0.542 1.000	0.137 1.000	0.074 0.999	0.061 0.992					
	50	1.000 1.000	0.774 1.000	0.162 1.000	0.066 1.000	0.051 1.000					
	100	1.000 1.000	0.956 1.000	0.211 1.000	0.054 1.000	0.035 1.000					

All the tests are conducted based on the statistic $\Gamma_{LM}^{B}(p)$ defined in (3.14) of the text. See Section 4.3.